

## 74AC843 • 74ACT843 9-Bit Transparent Latch

### General Description

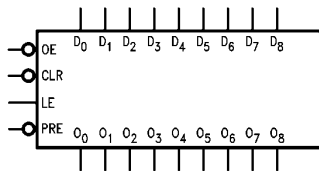
The 'AC/'ACT843 bus interface latch is designed to eliminate the extra packages required to buffer existing latches and provide extra data width for wider address/data paths.

The 'AC/'ACT843 is functionally and pin compatible with AMD's Am29843.

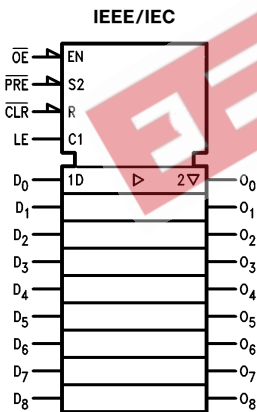
### Features

- 'ACT843 has TTL-compatible inputs
- TRI-STATE® outputs for bus interfacing

### Logic Symbols

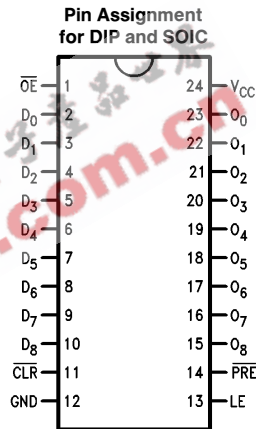


TL/F/9800-1



TL/F/9800-3

### Connection Diagram



TL/F/9800-2

Pin Names	Description
D <sub>0</sub> -D <sub>8</sub>	Data Inputs
O <sub>0</sub> -O <sub>8</sub>	Data Outputs
$\overline{OE}$	Output Enable
LE	Latch Enable
$\overline{CLR}$	Clear
PRE	Preset

TRI-STATE® is a registered trademark of National Semiconductor Corporation  
FACT™ is a trademark of National Semiconductor Corporation

## Functional Description

The 'AC/'ACT843 consists of nine D-type latches with TRI-STATE outputs. The flip-flops appear transparent to the data when Latch Enable (LE) is HIGH. This allows asynchronous operation, as the output transition follows the data in transition. On the LE HIGH-to-LOW transition, the data that meets the setup times is latched. Data appears on the bus when the Output Enable ( $\overline{OE}$ ) is LOW. When  $\overline{OE}$  is HIGH, the bus output is in the high impedance state. In

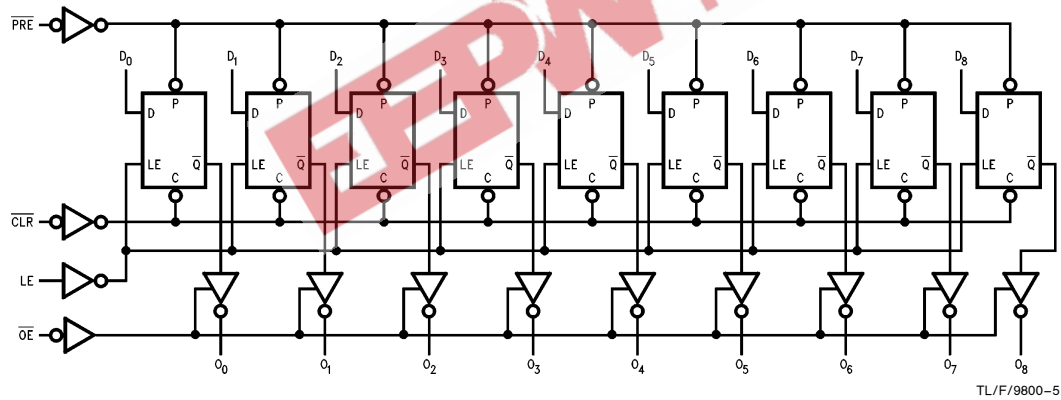
addition to the LE and  $\overline{OE}$  pins, the 'AC/'ACT843 has a Clear ( $\overline{CLR}$ ) pin and a Preset ( $\overline{PRE}$ ) pin. These pins are ideal for parity bus interfacing in high performance systems. When  $\overline{CLR}$  is LOW, the outputs are LOW if  $\overline{OE}$  is LOW. When  $\overline{CLR}$  is HIGH, data can be entered into the latch. When  $\overline{PRE}$  is LOW, the outputs are HIGH if  $\overline{OE}$  is LOW. Preset overrides  $\overline{CLR}$ .

Function Tables

Inputs					Internal	Outputs	Function
$\overline{CLR}$	$\overline{PRE}$	$\overline{OE}$	LE	D	Q	O	
H	H	H	H	L	L	Z	High Z
H	H	H	H	H	H	Z	High Z
H	H	H	L	X	NC	Z	Latched
H	H	L	H	L	L	L	Transparent
H	H	L	H	H	H	H	Transparent
H	H	L	L	X	NC	NC	Latched
H	L	L	X	X	H	H	Preset
L	H	L	X	X	L	L	Clear
L	L	L	X	X	H	H	Preset
L	H	H	L	X	L	Z	Clear/High Z
H	L	H	L	X	H	Z	Preset/High Z

H = HIGH Voltage Level  
 L = LOW Voltage Level  
 X = Immaterial  
 Z = High Impedance  
 NC = No Change

## Logic Diagram



### Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage ( $V_{CC}$ )	-0.5V to +7.0V
DC Input Diode Current ( $I_{IK}$ )	-20 mA +20 mA
DC Input Voltage ( $V_I$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current ( $I_{OK}$ )	-20 mA +20 mA
DC Output Voltage ( $V_O$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current ( $I_O$ )	$\pm 50$ mA
DC $V_{CC}$ or Ground Current per Output Pin ( $I_{CC}$ or $I_{GND}$ )	$\pm 50$ mA
Storage Temperature ( $T_{STG}$ )	-65°C to +150°C
Junction Temperature ( $T_J$ )	140°C

**Note 1:** Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT™ circuits outside databook specifications.

### Recommended Operating Conditions

Supply Voltage ( $V_{CC}$ )	2.0V to 6.0V
'AC	4.5V to 5.5V
'ACT	
Input Voltage ( $V_I$ )	0V to $V_{CC}$
Output Voltage ( $V_O$ )	0V to $V_{CC}$
Operating Temperature ( $T_A$ )	-40°C to +85°C
74AC/ACT	
Minimum Input Edge Rate ( $\Delta V/\Delta t$ )	
'AC Devices	
$V_{IN}$ from 30% to 70% of $V_{CC}$	125 mV/ns
$V_{CC}$ @ 3.3V, 4.5V, 5.5V	
Minimum Input Edge Rate ( $\Delta V/\Delta t$ )	
'ACT Devices	
$V_{IN}$ from 0.8V to 2.0V	125 mV/ns
$V_{CC}$ @ 4.5V, 5.5V	

### DC Electrical Characteristics for 'AC Family Devices

Symbol	Parameter	$V_{CC}$ (V)	74AC		Units	Conditions	
			$T_A = +25^\circ\text{C}$				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$
			Typ	Guaranteed Limits			
$V_{IH}$	Minimum High Level Input Voltage	3.0	1.5	2.1	2.1	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	2.25	3.15	3.15		
		5.5	2.75	3.85	3.85		
$V_{IL}$	Maximum Low Level Input Voltage	3.0	1.5	0.9	0.9	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	2.25	1.35	1.35		
		5.5	2.75	1.65	1.65		
$V_{OH}$	Minimum High Level Output Voltage	3.0	2.99	2.9	2.9	V	$I_{OUT} = -50 \mu A$
		4.5	4.49	4.4	4.4		
		5.5	5.49	5.4	5.4		
		3.0		2.56	2.46	V	* $V_{IN} = V_{IL}$ or $V_{IH}$ -12 mA $I_{OH}$ -24 mA -24 mA
		4.5		3.86	3.76		
		5.5		4.86	4.76		
$V_{OL}$	Maximum Low Level Output Voltage	3.0	0.002	0.1	0.1	V	$I_{OUT} = 50 \mu A$
		4.5	0.001	0.1	0.1		
		5.5	0.001	0.1	0.1		
		3.0		0.36	0.44	V	* $V_{IN} = V_{IL}$ or $V_{IH}$ 12 mA $I_{OL}$ 24 mA 24 mA
		4.5		0.36	0.44		
		5.5		0.36	0.44		
$I_{IN}$	Maximum Input Leakage Current	5.5		$\pm 0.1$	$\pm 1.0$	$\mu A$	$V_I = V_{CC}, GND$

\*All outputs loaded; thresholds on input associated with output under test.

### DC Electrical Characteristics for 'AC Family Devices (Continued)

Symbol	Parameter	V <sub>CC</sub> (V)	74AC		Units	Conditions	
			T <sub>A</sub> = +25°C				T <sub>A</sub> = -40°C to +85°C
			Typ	Guaranteed Limits			
I <sub>OZ</sub>	Maximum TRI-STATE Leakage Current	5.5		±0.5	±5.0	μA	V <sub>I</sub> (OE) = V <sub>IL</sub> , V <sub>IH</sub> V <sub>I</sub> = V <sub>CC</sub> , GND V <sub>O</sub> = V <sub>CC</sub> , GND
I <sub>OLD</sub>	†Minimum Dynamic Output Current	5.5			75	mA	V <sub>OLD</sub> = 1.65V Max
I <sub>OHD</sub>		5.5			-75	mA	V <sub>OHD</sub> = 3.85V Min
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5		8.0	80.0	μA	V <sub>IN</sub> = V <sub>CC</sub> or GND

†Maximum test duration 2.0 ms, one output loaded at a time.

Note: I<sub>IN</sub> and I<sub>CC</sub> @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V<sub>CC</sub>.

### DC Electrical Characteristics for 'ACT Family Devices

Symbol	Parameter	V <sub>CC</sub> (V)	74ACT		Units	Conditions	
			T <sub>A</sub> = +25°C				T <sub>A</sub> = -40°C to +85°C
			Typ	Guaranteed Limits			
V <sub>IH</sub>	Minimum High Level Input Voltage	4.5	1.5	2.0	2.0	V	V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V
		5.5	1.5	2.0	2.0		
V <sub>IL</sub>	Maximum Low Level Input Voltage	4.5	1.5	0.8	0.8	V	V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V
		5.5	1.5	0.8	0.8		
V <sub>OH</sub>	Minimum High Level Output Voltage	4.5	4.49	4.4	4.4	V	I <sub>OUT</sub> = -50 μA
		5.5	5.49	5.4	5.4		
		4.5		3.86	3.76	V	*V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> -24 mA I <sub>OH</sub> -24 mA
		5.5		4.86	4.76		
V <sub>OL</sub>	Maximum Low Level Output Voltage	4.5	0.001	0.1	0.1	V	I <sub>OUT</sub> = 50 μA
		5.5	0.001	0.1	0.1		
		4.5		0.36	0.44	V	*V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> 24 mA I <sub>OL</sub> 24 mA
		5.5		0.36	0.44		
I <sub>IN</sub>	Maximum Input Leakage Current	5.5		±0.1	±1.0	μA	V <sub>I</sub> = V <sub>CC</sub> , GND
I <sub>OZ</sub>	Maximum TRI-STATE Leakage Current	5.5		±0.5	±5.0	μA	V <sub>I</sub> = V <sub>IL</sub> , V <sub>IH</sub> V <sub>O</sub> = V <sub>CC</sub> , GND
I <sub>CCT</sub>	Maximum I <sub>CC</sub> /Input	5.5	0.6		1.5	mA	V <sub>I</sub> = V <sub>CC</sub> - 2.1V
I <sub>OLD</sub>	†Minimum Dynamic Output Current	5.5			75	mA	V <sub>OLD</sub> = 1.65V Max
I <sub>OHD</sub>		5.5			-75	mA	V <sub>OHD</sub> = 3.85V Min
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5		8.0	80.0	μA	V <sub>IN</sub> = V <sub>CC</sub> or GND

\*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics								
Symbol	Parameter	V <sub>CC</sub> * (V)	74AC			74AC		Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF			T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF		
			Min	Typ	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay D <sub>n</sub> to O <sub>n</sub>	3.3	3.5	6.5	12.0	2.5	13.0	ns
		5.0	2.0	4.5	8.5	1.5	9.0	
t <sub>PHL</sub>	Propagation Delay D <sub>n</sub> to O <sub>n</sub>	3.3	4.0	7.0	12.0	3.0	13.0	ns
		5.0	2.5	5.0	8.5	1.5	9.0	
t <sub>PLH</sub>	Propagation Delay LE to O <sub>n</sub>	3.3	3.5	6.5	12.0	13.0	2.5	ns
		5.0	2.0	4.5	8.5	1.5	9.0	
t <sub>PHL</sub>	Propagation Delay LE to O <sub>n</sub>	3.3	4.0	7.0	12.0	3.0	13.0	ns
		5.0	2.5	5.0	8.5	1.5	9.0	
t <sub>PLH</sub>	Propagation Delay $\overline{\text{PRE}}$ to O <sub>n</sub>	3.3	5.5	8.5	19.0	4.5	21.5	ns
		5.0	3.5	6.0	13.0	2.5	14.5	
t <sub>PHL</sub>	Propagation Delay $\overline{\text{CLR}}$ to O <sub>n</sub>	3.3	7.5	11.0	21.5	6.0	24.0	ns
		5.0	5.0	7.5	15.0	4.0	17.0	
t <sub>PZH</sub>	Output Enable Time $\overline{\text{OE}}$ to O <sub>n</sub>	3.3	3.5	6.0	11.0	3.0	12.0	ns
		5.0	2.0	4.5	8.0	1.5	9.0	
t <sub>PZL</sub>	Output Enable Time $\overline{\text{OE}}$ to O <sub>n</sub>	3.3	4.0	6.5	11.0	2.5	12.0	ns
		5.0	2.0	5.0	8.0	1.5	9.0	
t <sub>PHZ</sub>	Output Disable Time $\overline{\text{OE}}$ to O <sub>n</sub>	3.3	4.0	6.5	10.5	3.5	11.0	ns
		5.0	3.0	5.0	8.0	2.5	8.5	
t <sub>PLZ</sub>	Output Disable Time $\overline{\text{OE}}$ to O <sub>n</sub>	3.3	3.0	6.0	10.5	2.5	11.0	ns
		5.0	2.0	4.5	8.0	1.5	8.5	
t <sub>PHL</sub>	Propagation Delay $\overline{\text{PRE}}$ to O <sub>n</sub>	3.3	4.5	7.0	12.5	3.5	13.5	ns
		5.0	3.0	5.0	9.0	2.0	9.5	
t <sub>PLH</sub>	Propagation Delay $\overline{\text{CLR}}$ to O <sub>n</sub>	3.3	4.5	7.0	12.5	3.5	13.5	ns
		5.0	3.0	5.0	9.0	2.0	9.5	

\*Voltage Range 3.3 is 3.3V ±0.3V  
\*Voltage Range 5.0 is 5.0V ±0.5V

## AC Operating Requirements

Symbol	Parameter	V <sub>CC</sub> * (V)	74AC		74AC	Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF		T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF	
			Typ	Guaranteed Minimum		
t <sub>s</sub>	Setup Time, HIGH or LOW D <sub>n</sub> to LE	3.3	0	3.0	3.5	ns
		5.0	-0.5	1.5	2.0	
t <sub>h</sub>	Hold Time, HIGH or LOW D <sub>n</sub> to LE	3.3		2.0	2.0	ns
		5.0	-0.5	2.5	2.5	
t <sub>w</sub>	LE Pulse Width, HIGH	3.3	1.5	3.0	3.0	ns
		5.0	1.5	3.0	3.0	
t <sub>w</sub>	PRE Pulse Width, LOW	3.3	5.0	12.0	14.5	ns
		5.0	3.0	8.5	10.0	
t <sub>w</sub>	CLR Pulse Width, LOW	3.3	5.5	14.0	16.5	ns
		5.0	4.0	10.0	12.0	
t <sub>rec</sub>	PRE Recovery Time	3.3	1.0	3.0	3.0	ns
		5.0	0	1.5	1.5	
t <sub>rec</sub>	CLR Recovery Time	3.3	0	1.5	1.5	ns
		5.0	-0.5	0.5	0.5	

\*Voltage Range 3.3 is 3.3V ±0.3V

\*Voltage Range 5.0 is 5.0V ±0.5V

EEPW.com.cn 电子产品世界

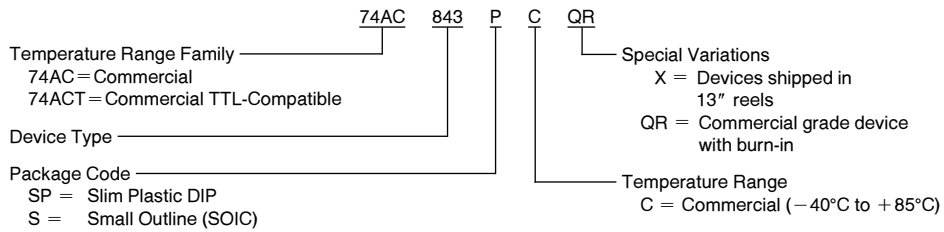
AC Electrical Characteristics								
Symbol	Parameter	V <sub>CC</sub> * (V)	74ACT			74ACT		Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF			T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF		
			Min	Typ	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay D <sub>n</sub> to O <sub>n</sub>	5.0	2.5	5.5	9.5	2.0	10.0	ns
t <sub>PHL</sub>	Propagation Delay D <sub>n</sub> to O <sub>n</sub>	5.0	2.5	5.5	9.5	2.0	10.0	ns
t <sub>PLH</sub>	Propagation Delay LE to O <sub>n</sub>	5.0	2.5	5.5	9.0	2.0	10.0	ns
t <sub>PHL</sub>	Propagation Delay LE to O <sub>n</sub>	5.0	2.5	5.5	9.0	2.0	10.0	ns
t <sub>PLH</sub>	Propagation Delay $\overline{\text{PRE}}$ to O <sub>n</sub>	5.0	2.5	6.5	14.0	2.0	16.0	ns
t <sub>PHL</sub>	Propagation Delay $\overline{\text{CLR}}$ to O <sub>n</sub>	5.0	2.5	7.5	15.5	2.0	17.5	ns
t <sub>pZH</sub>	Output Enable Time $\overline{\text{OE}}$ to O <sub>n</sub>	5.0	2.5	5.5	9.5	2.0	10.5	ns
t <sub>pZL</sub>	Output Enable Time $\overline{\text{OE}}$ to O <sub>n</sub>	5.0	2.5	5.5	9.5	2.0	10.5	ns
t <sub>pHZ</sub>	Output Disable Time $\overline{\text{OE}}$ to O <sub>n</sub>	5.0	2.5	6.0	10.5	2.0	11.0	ns
t <sub>pLZ</sub>	Output Disable Time $\overline{\text{OE}}$ to O <sub>n</sub>	5.0	2.5	6.0	10.5	2.0	11.0	ns
t <sub>PHL</sub>	Propagation Delay $\overline{\text{PRE}}$ to O <sub>n</sub>	5.0	2.5	6.0	10.5	2.0	11.0	ns
t <sub>PLH</sub>	Propagation Delay $\overline{\text{CLR}}$ to O <sub>n</sub>	5.0	2.5	5.5	9.5	2.0	10.5	ns
*Voltage Range 5.0 is 5.0V ±0.5V								
AC Operating Requirements								
Symbol	Parameter	V <sub>CC</sub> * (V)	74AC		74AC		Units	
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF		T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF			
			Typ	Guaranteed Minimum				
t <sub>s</sub>	Setup Time, HIGH or LOW D <sub>n</sub> to LE	5.0	-0.5	0.5	1.0	ns		
t <sub>h</sub>	Hold Time, HIGH or LOW D <sub>n</sub> to LE	5.0	0.5	2.0	2.0	ns		
t <sub>w</sub>	LE Pulse Width, HIGH	5.0	2.0	3.5	3.5	ns		
t <sub>w</sub>	$\overline{\text{PRE}}$ Pulse Width, LOW	5.0	5.0	8.5	10.0	ns		
t <sub>w</sub>	$\overline{\text{CLR}}$ Pulse Width, LOW	5.0	5.5	9.5	11.0	ns		
t <sub>rec</sub>	$\overline{\text{PRE}}$ Recovery Time	5.0	0.5	2.0	2.0	ns		
t <sub>rec</sub>	$\overline{\text{CLR}}$ Recovery Time	5.0	-0.5	1.0	1.0	ns		
*Voltage Range 5.0 is 5.0V ±0.5V								

## Capacitance

Symbol	Parameter	Typ	Units	Conditions
C <sub>IN</sub>	Input Capacitance	4.5	pF	V <sub>CC</sub> = OPEN
C <sub>PD</sub>	Power Dissipation Capacitance	44	pF	V <sub>CC</sub> = 5.0V

## Ordering Information

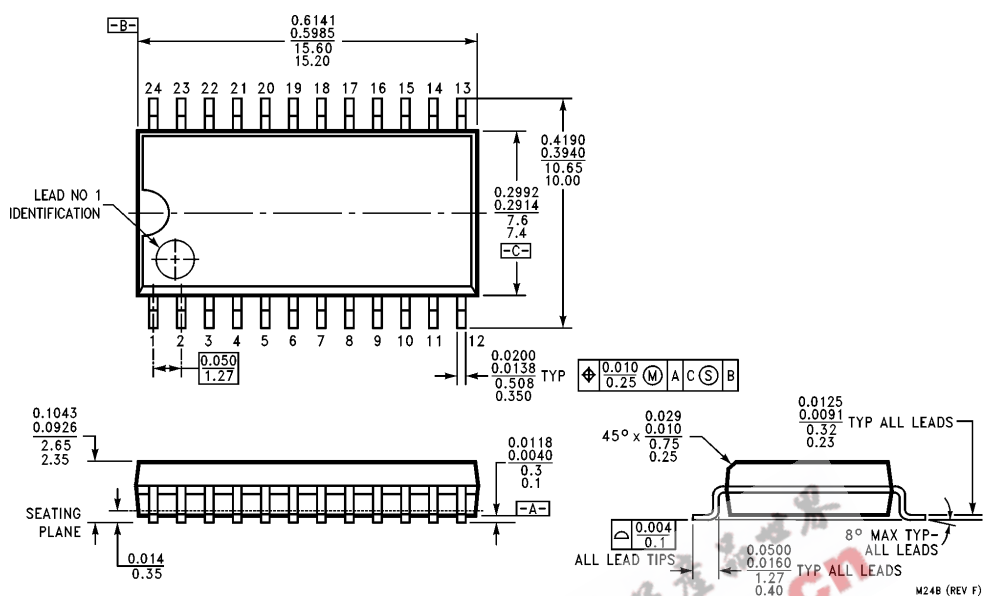
The device number is used to form part of a simplified purchasing code where a package type and temperature range are defined as follows:



EEPW.com.cn

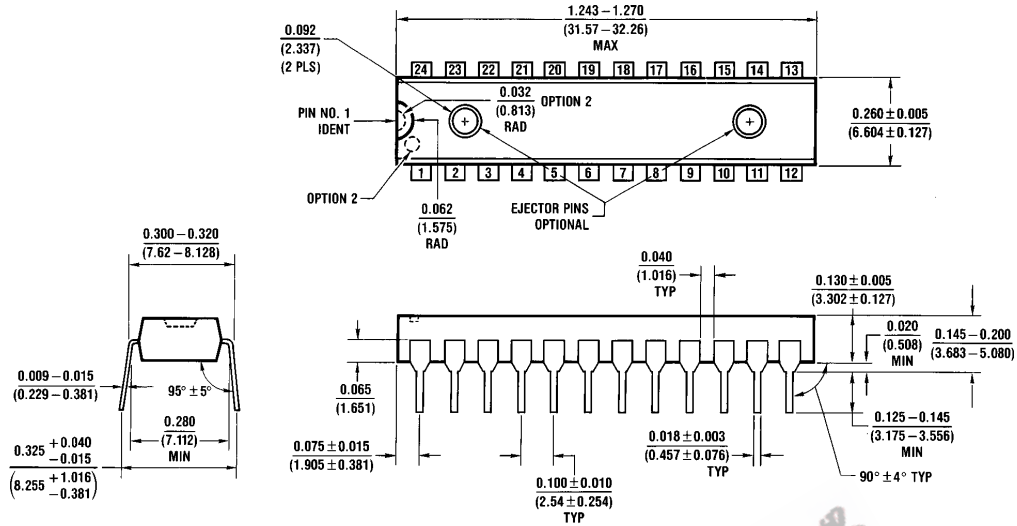


**Physical Dimensions** inches (millimeters)



**Physical Dimensions** inches (millimeters) (Continued)

Lit. # 114638



24-Lead Slim (0.300" Wide) Plastic Dual-In-Line Package (SP)  
NS Package Number N24C

N24C (REV F)



**LIFE SUPPORT POLICY**

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

 <p><b>National Semiconductor Corporation</b> 2900 Semiconductor Drive P.O. Box 58090 Santa Clara, CA 95052-8090 Tel: 1 (800) 272-9959 TWX: (910) 339-9240</p>	<p><b>National Semiconductor GmbH</b> Livry-Gargan-Str. 10 D-82256 Fürstenfeldbruck Germany Tel: (81-41) 35-0 Telex: 527649 Fax: (81-41) 35-1</p>	<p><b>National Semiconductor Japan Ltd.</b> Sumitomo Chemical Engineering Center Bldg. 7F 1-7-1, Nakase, Mihama-Ku Chiba-City, Chiba Prefecture 261 Tel: (043) 299-2300 Fax: (043) 299-2500</p>	<p><b>National Semiconductor Hong Kong Ltd.</b> 13th Floor, Straight Block, Ocean Centre, 5 Canton Rd. Tsimshatsui, Kowloon Hong Kong Tel: (852) 2737-1600 Fax: (852) 2736-9960</p>	<p><b>National Semicondutores Do Brazil Ltda.</b> Rue Deputado Lacorda Franco 120-3A Sao Paulo-SP Brazil 05418-000 Tel: (55-11) 212-5066 Telex: 391-1131931 NSBR BR Fax: (55-11) 212-1181</p>	<p><b>National Semiconductor (Australia) Pty, Ltd.</b> Building 16 Business Park Drive Monash Business Park Nottingham, Melbourne Victoria 3169 Australia Tel: (3) 558-9889 Fax: (3) 558-9998</p>
---	---	---	---	---	---

National does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.